


<b>Search Notes</b>  	<b>Application/Control No.</b>  10528662	<b>Applicant(s)/Patent Under Reexamination</b>  CHAPMAN ET AL.
	<b>Examiner</b>  Richey, Scott M	<b>Art Unit</b>  2877

SEARCHED			
Class	Subclass	Date	Examiner
356	450, 510	3/12/2007	SMR
359	211	3/13/2007	SMR
356	450	8/16/2007	SMR
359	837	8/16/2007	SMR

SEARCH NOTES		
Search Notes	Date	Examiner
Consulted Primary Examiner Andrew Lee	7/19/2007	SMR
Consulted Examiner Patrick Connolly regarding allowable subject matter	8/15/2007	SMR

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
PG Pub	(laser beam adjustable rotational alignment required).clm. operator: AND	8/16/2007	SMR